



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re patent application of

Hamid K. Aghajan

Serial No.: 09/365,517

Filed: August 2, 1999

For: Two-Dimensional Scatter Plot
Technique for Defect Detection

Group Art Unit: 2625

Examiner: J. K. Patel

Date: January 26, 2004

CERTIFICATE OF MAILING under 37 C.F.R. 1.8(a)

I hereby certify that this correspondence is being deposited on January 26, 2004 with the United States Postal Service as first class mail, with sufficient postage, in an envelope addressed to Commissioner for Patents, P.O. Box 1450, Alexandria, Virginia 22313-1450.

Michael B. Einschlag
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January 26, 2004

Date of Signature

Commissioner for Patents
P.O. Box 1450
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Sir:

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Technology Center 2600

This is in response to an Office Action mailed October 1, 2003. An Extension Petition is attached hereto to extend the time for responding by one (1) months from January 1, 2004 to and including February 1, 2004.